

FEATURES

- Monolithic 40 MSPS Converter
- 160 mW Power Dissipation
- On-Chip Track-and-Hold
- Single +5 V Power Supply
- TTL/CMOS Outputs
- 5 pF Input Capacitance
- Low Cost
- Tri-State Output Buffers
- High ESD Protection: 3,500 V Minimum
- Selectable +3 V or +5 V Logic I/O

APPLICATIONS

- All High-Speed Applications Where Low Power Dissipation is Required
- Video Imaging
- Medical Imaging
- Radar Receivers
- IR Imaging
- Digital Communications

GENERAL DESCRIPTION

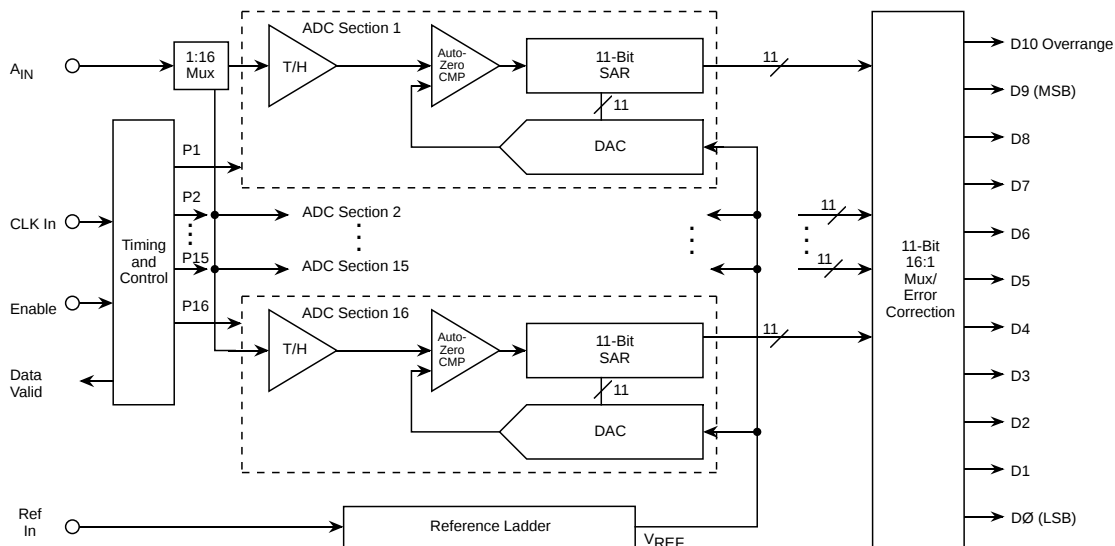
The SPT7863 is a 10-bit monolithic, low cost, ultralow power analog-to-digital converter capable of minimum word rates of 40 MSPS. The on-chip track-and-hold function assures very good dynamic performance without the need for external components. The input drive requirements are minimized due to the SPT7863's low input capacitance of only 5 pF.

Power dissipation is extremely low at only 160 mW typical at 40 MSPS with a power supply of +5.0 V. The digital outputs

are +3 V or +5 V, and are user selectable. The SPT7863 is pin-compatible with the entire family of SPT 10-bit, CMOS converters (SPT7835/40/50/55/60/61) which simplifies upgrades. The SPT7863 has incorporated proprietary circuit design and CMOS processing technologies to achieve its advanced performance. Inputs and outputs are TTL/CMOS compatible to interface with TTL/CMOS logic systems. Output data format is straight binary.

The SPT7863 is available in 28-lead SOIC and 32-lead small (7 mm square) TQFP packages over the commercial temperature range.

BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS (Beyond which damage may occur)¹ 25 °C

Supply Voltages

AV_{DD} +6 V
DV_{DD} +6 V

Input Voltages

Analog Input -0.5 V to AV_{DD} +0.5 V
V_{REF} 0 to AV_{DD}
CLK Input V_{DD}
AV_{DD} - DV_{DD} ±100 mV
AGND - DGND ±100 mV

Output

Digital Outputs 10 mA

Temperature

Operating Temperature 0 to +70 °C
Junction Temperature +175 °C
Lead Temperature, (soldering 10 seconds) +300 °C
Storage Temperature -65 to +150 °C

Note: 1. Operation at any Absolute Maximum Rating is not implied. See Electrical Specifications for proper nominal applied conditions in typical applications.

ELECTRICAL SPECIFICATIONS

T_A=T_{MAX} to T_{MAX}, AV_{DD}=DV_{DD}=+5.0 V, V_{IN}=0 to 4 V, f_S=40 MSPS, V_{RHS}=4.0 V, V_{RLS}=0.0 V, unless otherwise specified.

PARAMETERS	TEST CONDITIONS	TEST LEVEL	MIN	SPT7863 TYP	MAX	UNITS
Resolution			10			Bits
DC Accuracy						
Integral Nonlinearity		VI		±1.0		LSB
Differential Nonlinearity		VI		±0.5		LSB
No Missing Codes		VI		Guaranteed		
Analog Input						
Input Voltage Range		VI	V _{RLS}		V _{RHS}	V
Input Resistance		IV	50			kΩ
Input Capacitance		V		5.0		pF
Input Bandwidth	(Small Signal)	V	250			MHz
Offset		V		±2.0		LSB
Gain Error		V		±0.2		%
Reference Input						
Resistance		VI	300	500	600	Ω
Bandwidth		V	100	150		MHz
Voltage Range						
V _{RLS}		IV	0	-	2.0	V
V _{RHS}		IV	3.0	-	AV _{DD}	V
V _{RHS} - V _{RLS}		V	1.0	4.0	5.0	V
Δ(V _{RHF} - V _{RHS})		V		90		mV
Δ(V _{RLS} - V _{RLE})		V		75		mV
Reference Settling Time						
V _{RHS}		V		15		Clock Cycles
V _{RLS}		V		20		Clock Cycles
Conversion Characteristics						
Maximum Conversion Rate		VI	40			MHz
Minimum Conversion Rate		IV	2			MHz
Pipeline Delay (Latency)		IV			12	Clock Cycles
Aperture Delay Time		V		4.0		ns
Aperture Jitter Time		V		30		ps(p-p)
Dynamic Performance						
Effective Number of Bits						
f _{IN} =3.58 MHz		VI		9.2		Bits
f _{IN} =10 MHz		V		8.7		Bits

ELECTRICAL SPECIFICATIONS

$T_A = T_{MAX}$ to T_{MAX} , $AV_{DD} = DV_{DD} = +5.0$ V, $V_{IN} = 0$ to 4 V, $f_S = 40$ MSPS, $V_{RHS} = 4.0$ V, $V_{RLS} = 0.0$ V, unless otherwise specified.

PARAMETERS	TEST CONDITIONS	TEST LEVEL	MIN	SPT7863 TYP	MAX	UNITS
Dynamic Performance						
Signal-to-Noise Ratio (without Harmonics)						
$f_{IN} = 3.58$ MHz		VI	55	57		dB
$f_{IN} = 10$ MHz		V		54		dB
Harmonic Distortion						
$f_{IN} = 3.58$ MHz		VI	64	67		dB
$f_{IN} = 10$ MHz		V		62		dB
Signal-to-Noise and Distortion (SINAD)						
$f_{IN} = 3.58$ MHz		VI	54	57		dB
$f_{IN} = 10$ MHz		V		54		dB
Spurious Free Dynamic Range	$f_{IN} = 3.580$ MHz	V		70		dB
Differential Phase		V		± 0.3		Degree
Differential Gain		V		± 0.3		%
Inputs						
Logic 1 Voltage		VI	2.0			V
Logic 0 Voltage		VI			0.8	V
Maximum Input Current Low		VI	-10		+10	μ A
Maximum Input Current High		VI	-10		+10	μ A
Input Capacitance		V		+5		pF
Digital Outputs						
Logic 1 Voltage	$I_{OH} = 0.5$ mA	VI	3.5			V
Logic 0 Voltage	$I_{OL} = 1.6$ mA	VI			0.4	V
t_{RISE}	15 pF load	V		10		ns
t_{FALL}	15 pF load	V		10		ns
Output Enable to Data Output Delay	20 pF load, $T_A = +25$ °C	V		10		ns
	50 pF load over temp.	V		22		ns
Power Supply Requirements						
Voltages						
OV_{DD}		IV	3.0		5.0	V
DV_{DD}		IV	4.75	5.0	5.25	V
AV_{DD}		IV	4.75	5.0	5.25	V
Currents						
AI_{DD}		VI		17	21	mA
DI_{DD}		VI		16	21	mA
Power Dissipation		VI		160	210	mW

TEST LEVEL CODES

All electrical characteristics are subject to the following conditions:

All parameters having min/max specifications are guaranteed. The Test Level column indicates the specific device testing actually performed during production and Quality Assurance inspection. Any blank section in the data column indicates that the specification is not tested at the specified condition.

TEST LEVEL

TEST PROCEDURE

I	100% production tested at the specified temperature.
II	100% production tested at $T_A = +25$ °C, and sample tested at the specified temperatures.
III	QA sample tested only at the specified temperatures.
IV	Parameter is guaranteed (but not tested) by design and characterization data.
V	Parameter is a typical value for information purposes only.
VI	100% production tested at $T_A = +25$ °C. Parameter is guaranteed over specified temperature range.

Figure 1A: Timing Diagram 1

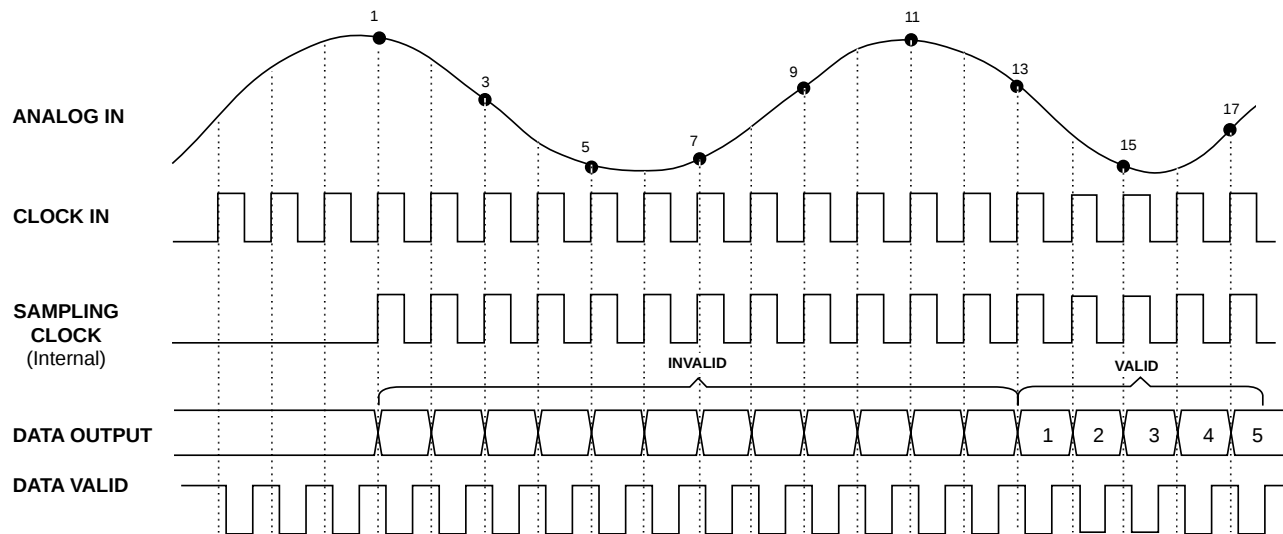


Figure 1B: Timing Diagram 2

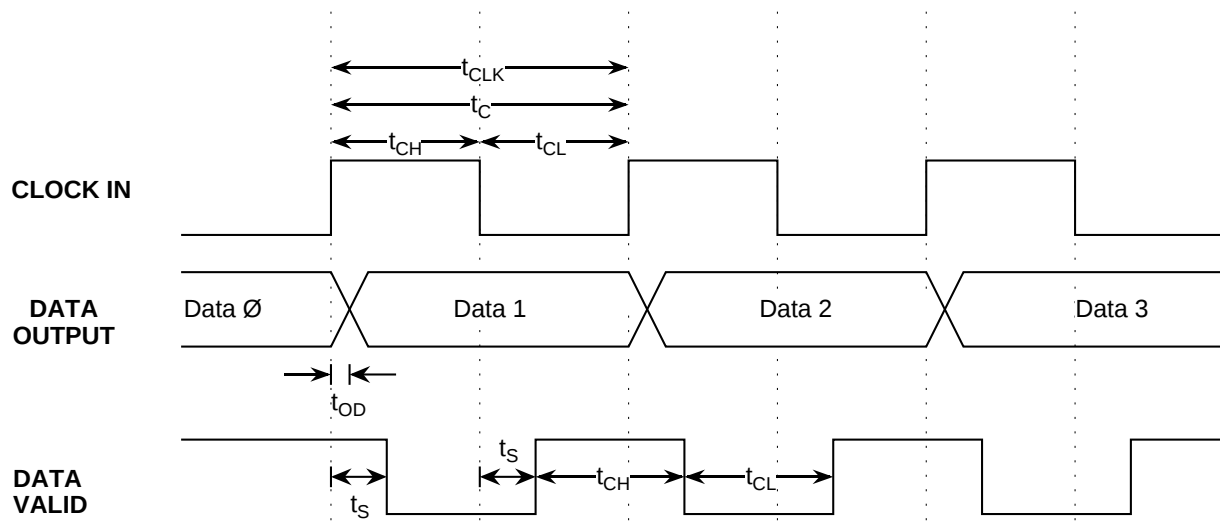


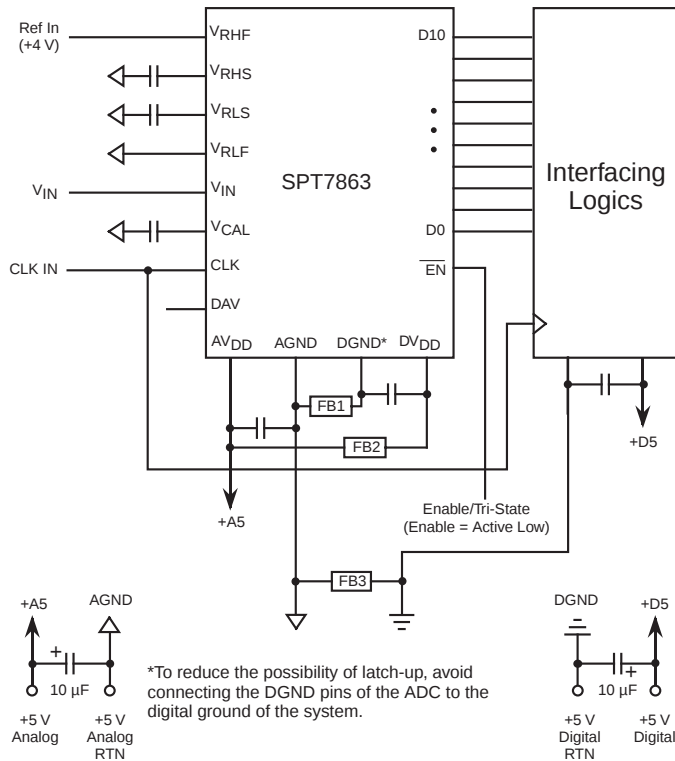
Table I - Timing Parameters

DESCRIPTION	PARAMETERS	MIN	TYP	MAX	UNITS
Conversion Time	t_C	t_{CLK}			ns
Clock Period	t_{CLK}	25			ns
Clock High Duty Cycle	t_{CH}	40	50	60	%
Clock Low Duty Cycle	t_{CL}	40	50	60	%
Clock to Output Delay (15 pF Load)	t_{OD}		17		ns
Clock to DAV	t_S		10		ns

TYPICAL INTERFACE CIRCUIT

Very few external components are required to achieve the stated device performance. Figure 1 shows the typical interface requirements when using the SPT7863 in normal circuit operation. The following sections provide descriptions of the major functions and outline critical performance criteria to consider for achieving the optimal device performance.

Figure 1 - Typical Interface Circuit



POWER SUPPLIES AND GROUNDING

SPT suggests that both the digital and the analog supply voltages on the SPT7863 be derived from a single analog supply as shown in figure 1. A separate digital supply should be used for all interface circuitry. SPT suggests using this power supply configuration to prevent a possible latch-up condition on power up.

OPERATING DESCRIPTION

The general architecture for the CMOS ADC is shown in the block diagram. The design contains 16 identical successive approximation ADC sections, all operating in parallel, a 16-phase clock generator, an 11-bit 16:1 digital output multiplexer, correction logic, and a voltage reference generator which provides common reference levels for each ADC section.

The high sample rate is achieved by using multiple SAR ADC sections in parallel, each of which samples the input signal in sequence. Each ADC uses 16 clock cycles to complete a conversion. The clock cycles are allocated as follows:

Table II - Clock Cycles

Clock	Operation
1	Reference zero sampling
2	Auto-zero comparison
3	Auto-calibrate comparison
4	Input sample
5-15	11-bit SAR conversion
16	Data transfer

The 16 phase clock, which is derived from the input clock, synchronizes these events. The timing signals for adjacent ADC sections are shifted by one clock cycle so that the analog input is sampled on every cycle of the input clock by exactly one ADC section. After 16 clock periods, the timing cycle repeats. The latency from analog input sample to the corresponding digital output is 12 clock cycles.

- Since only 16 comparators are used, a huge power savings is realized.
- The auto-zero operation is done using a closed loop system that uses multiple samples of the comparators response to a reference zero.
- The auto-calibrate operation, which calibrates the gain of the MSB reference and the LSB reference, is also done with a closed loop system. Multiple samples of the gain error are integrated to produce a calibration voltage for each ADC section.
- Capacitive displacement currents, which can induce sampling error, are minimized since only one comparator samples the input during a clock cycle.
- The total input capacitance is very low since sections of the converter which are not sampling the signal are isolated from the input by transmission gates.

VOLTAGE REFERENCE

The SPT7863 requires the use of a single external voltage reference for driving the high side of the reference ladder. It must be within the range of 3 V to 5 V. The lower side of the ladder is typically tied to AGND (0.0 V), but can be run up to 2.0 V with a second reference. The analog input voltage range will track the total voltage difference measured between the ladder sense lines, VRHS and VRLS.

Force and sense taps are provided to ensure accurate and stable setting of the upper and lower ladder sense line voltages across part-to-part and temperature variations. By using the configuration shown in figure 2, offset and gain errors of less than ± 2 LSB can be obtained.

Pin diagram of the ADXL035 accelerometer:

- 1: AGND
- 2: V_{RHF}
- 3: V_{RHS}
- 4: N/C
- 5: V_{RLS}
- 6: V_{RLF}
- 7: V_{IN}

+4.0 V
External
Reference

V_{RHS}
(+3.91 V)

V_{RLS}
(0.075 V)

V_{RLF} (AGND)
0.0 V

90 mV

75 mV

$R/2$

R

R

R

R

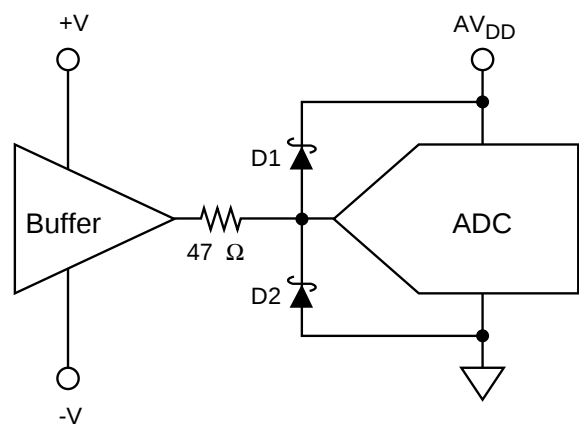
R

R

$R/2$

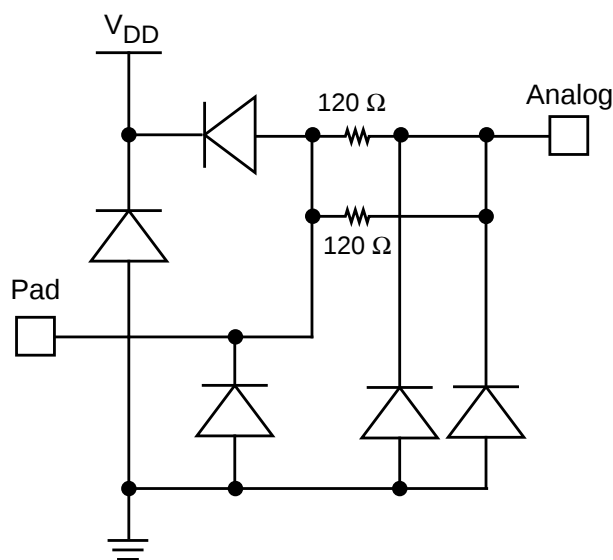
$R=30\ \Omega$ (typ)
All capacitors are 0.01 μF

Figure 4 - Recommended Input Protection Circuit



D1 = D2 = Hewlett Packard HP5712 or equivalent

Figure 5 - On-Chip Protection Circuit



CLOCK INPUT

The SPT7863 is driven from a single-ended TTL-input clock. Because the pipelined architecture operates on the rising edge of the clock input, the device can operate over a wide range of input clock duty cycles without degrading the dynamic performance.

DIGITAL OUTPUTS

The digital outputs (D0-D10) are driven by a separate supply (OV_{DD}) ranging from +3 V to +5 V. This feature makes it possible to drive the SPT7863's TTL/CMOS-compatible outputs with the user's logic system supply. The format of the output data (D0-D9) is straight binary. (See table III.) The outputs are latched on the rising edge of CLK. These outputs can be switched into a tri-state mode by bringing $\overline{EN}$ high.

Table III - Output Data Information

ANALOG INPUT	OVERRANGE D10	OUTPUT CODE D9-D0
+F.S. + 1/2 LSB	1	11 1111 1111
+F.S. -1/2 LSB	0	11 1111 1110
+1/2 F.S.	0	00 0000 0000
+1/2 LSB	0	00 0000 0000
0.0 V	0	00 0000 0000

(Ø indicates the flickering bit between logic 0 and 1).

OVERRANGE OUTPUT

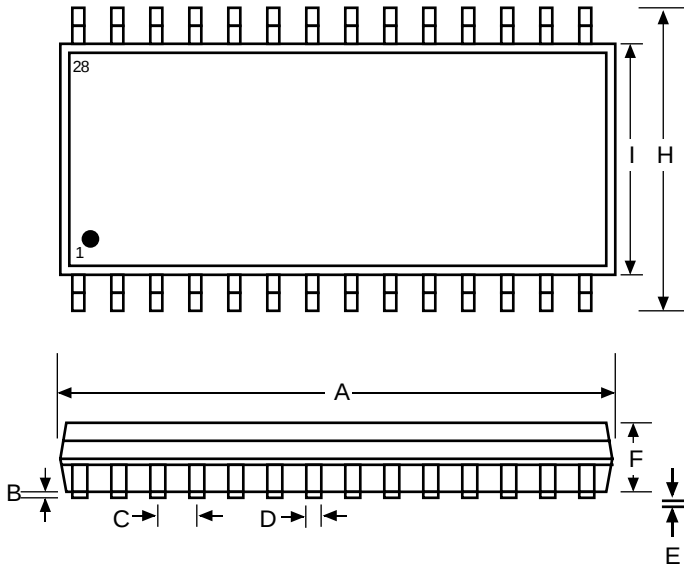
The OVERRANGE OUTPUT (D10) is an indication that the analog input signal has exceeded the positive full scale input voltage by 1 LSB. When this condition occurs, D10 will switch to logic 1. All other data outputs (D0 to D9) will remain at logic 1 as long as D10 remains at logic 1. This feature makes it possible to include the SPT7863 into higher resolution systems.

EVALUATION BOARD

The EB7863 evaluation board is available to aid designers in demonstrating the full performance of the SPT7863. This board includes a reference circuit, clock driver circuit, output data latches and an on-board reconstruction of the digital data. An application note describing the operation of this board as well as information on the testing of the SPT7863 is also available. Contact the factory for price and availability.

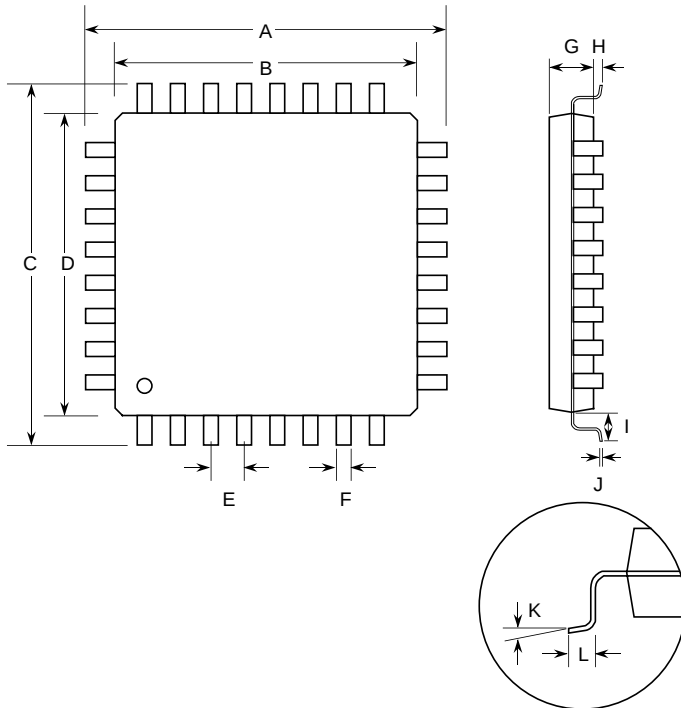
PACKAGE OUTLINES

28-Lead SOIC



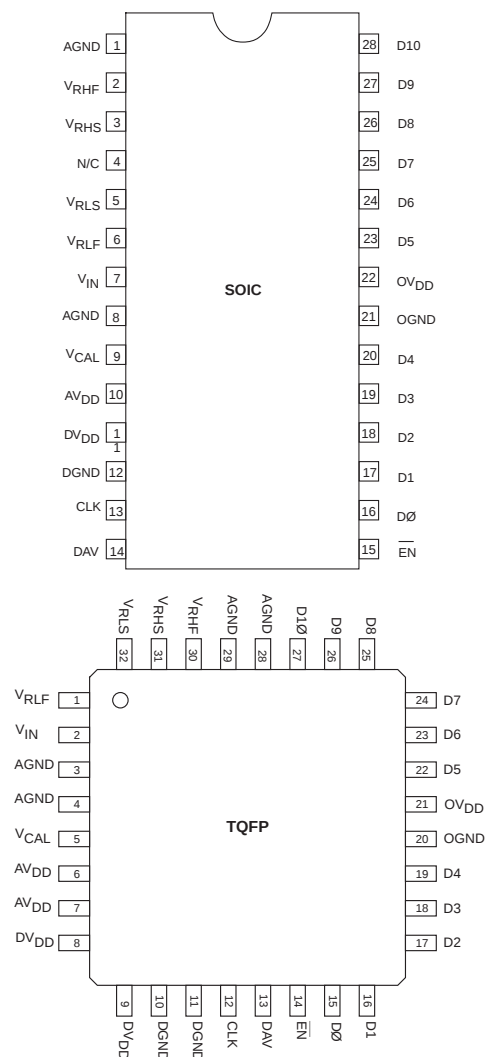
SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.696	0.712	17.68	18.08
B	0.004	0.012	0.10	0.30
C		.050 typ	0.00	1.27
D	0.014	0.019	0.36	0.48
E	0.009	0.012	0.23	0.30
F	0.080	0.100	2.03	2.54
G	0.016	0.050	0.41	1.27
H	0.394	0.419	10.01	10.64
I	0.291	0.299	7.39	7.59

32-Lead TQFP



SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.347	0.355	8.90	9.10
B	0.269	0.277	6.90	7.10
C	0.347	0.355	8.90	9.10
D	0.269	0.277	6.90	7.10
E	0.027	0.035	0.68	0.89
F	0.012	0.018	0.30	0.45
G	0.053	0.057	1.35	1.45
H	0.002	0.006	0.05	0.15
I	0.039 typ		1.00 typ	
J	0.004	0.008	0.09	0.20
K	0°	7°	0°	7°
L	0.018	0.029	0.45	0.75

PIN ASSIGNMENTS



PIN FUNCTIONS

Name	Function
AGND	Analog Ground
V _{RHF}	Reference High Force
V _{RHS}	Reference High Sense
V _{RLS}	Reference Low Sense
V _{RFL}	Reference Low Force
V _{CAL}	Calibration Reference
V _{IN}	Analog Input
AV _{DD}	Analog V _{DD}
DV _{DD}	Digital V _{DD}
DGND	Digital Ground
CLK	Input Clock f _{CLK} =fs (TTL)
$\overline{\text{EN}}$	Output Enable
D0-9	Tri-State Data Output, (D0=LSB)
D10	Tri-State Output Overrange
DAV	Data Valid Output
OV _{DD}	Digital Output Supply
OGND	Digital Output Ground

ORDERING INFORMATION

PART NUMBER	TEMPERATURE RANGE	PACKAGE TYPE
SPT7863SCS	0 to +70 °C	28L SOIC
SPT7863SCT	0 to +70 °C	32L TQFP

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Covered by Patent Numbers 5262779 and 5272481.

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